

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination KOJIMA ET AL.	
		Examiner Oanh L. Duong	Art Unit 2155	Page 1 of 1

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U.S. PATENT DOCUMENTS

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
A	US-2003/0115277	06-2003	WATANABE et al.	709/207
B	US-2001/0042093	11-2001	SHIRAI et al.	709/201
C	US-2002/0059362	05-2002	MAEDA, TORU	709/203
D	US-6,041,689 6,014,689	01-2000	Budge , et al	709/206
E	US-6,553,374	04-2003	Yamamoto et al.	707/9
F	US-6,192,396	02-2001	Kohler, Timothy L.	709/206
G	US-6,073,133	06-2000	Chrabszcz, Michael P.	707/10
H	US-6,545,768	04-2003	Matsubara et al.	358/1.15
I	US-			
J	US-			
K	US-			
L	US-			
M	US-			

IDC-For Ref -1

FOREIGN PATENT DOCUMENTS

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
N	JP 2000339239 A	12-2000	Japan	KATO, SHINICHIRO	G06F 13/00
O					
P					
Q					
R					
S					
T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

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